SN54F241, SN74F241
OCTAL BUFFERS/DRIVERS
WITH 3-STATE OUTPUTS
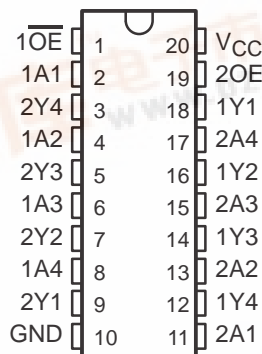
SDFS090 – MARCH 1987 – REVISED OCTOBER 1993

- **3-State Outputs Drive Bus Lines or Buffer Memory Address Registers**
- **Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Plastic and Ceramic DIPs**
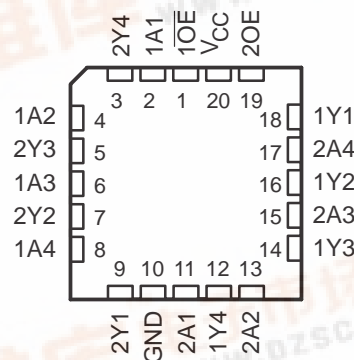
description

These octal buffers and line drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. Taken together with the ′F240 and ′F244, these devices provide the choice of selected combinations of inverting and noninverting outputs, symmetrical $\overline{OE}$ (active-low output-enable) inputs, and complementary OE and $\overline{OE}$ inputs.

The SN54F241 is characterized for operation over the full military temperature range of −55°C to 125°C. The SN74F241 is characterized for operation from 0°C to 70°C.

SN54F241 . . . J PACKAGE
SN74F241 . . . DW OR N PACKAGE
(TOP VIEW)

1$\overline{OE}$	1		20	V_{CC}
1A1	2		19	2OE
2Y4	3		18	1Y1
1A2	4		17	2A4
2Y3	5		16	1Y2
1A3	6		15	2A3
2Y2	7		14	1Y3
1A4	8		13	2A2
2Y1	9		12	1Y4
GND	10		11	2A1

SN54F241 . . . FK PACKAGE
(TOP VIEW)

Top pins: 2Y4, 1A1, 1$\overline{OE}$, V_{CC}, 2OE (pins 3, 2, 1, 20, 19)

1A2	4	18	1Y1
2Y3	5	17	2A4
1A3	6	16	1Y2
2Y2	7	15	2A3
1A4	8	14	1Y3

Bottom pins: 2Y1, GND, 2A1, 1Y4, 2A2 (pins 9, 10, 11, 12, 13)

FUNCTION TABLES

INPUTS		OUTPUT
1$\overline{OE}$	1A	1Y
H	X	Z
L	H	H
L	L	L

INPUTS		OUTPUT
2OE	2A	2Y
H	H	H
H	L	L
L	X	Z

TEXAS INSTRUMENTS

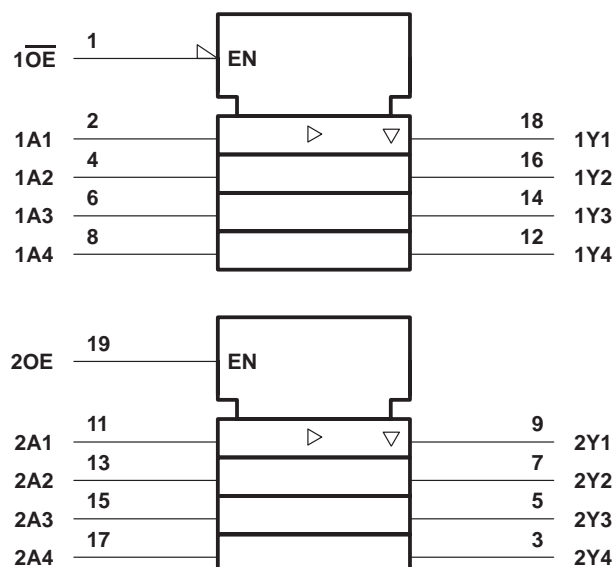Copyright © 1993, Texas Instruments Incorporated

SN54F241, SN74F241
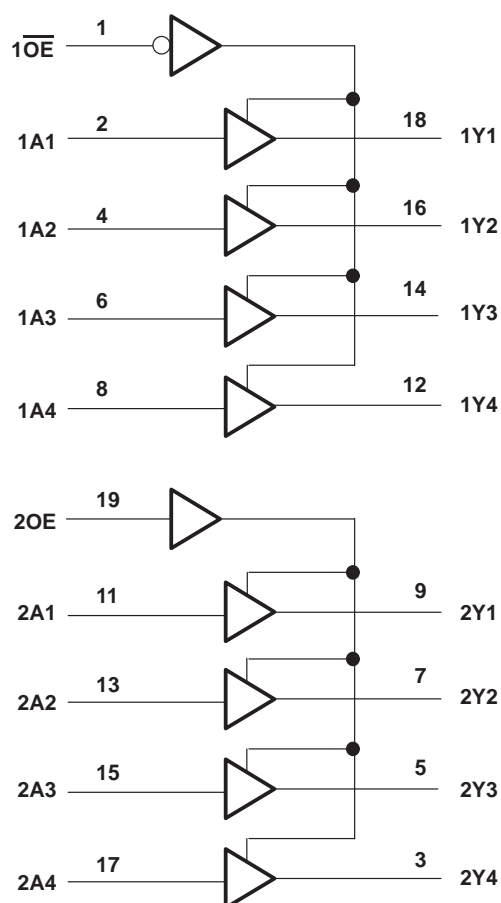# OCTAL BUFFERS/DRIVERS
WITH 3-STATE OUTPUTS

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logic symbol†

† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V_{CC}	−0.5 V to 7 V
Input voltage range, V_I (see Note 1)	−1.2 V to 7 V
Input current range	−30 mA to 5 mA
Voltage range applied to any output in the disabled or power-off state	−0.5 V to 5.5 V
Voltage range applied to any output in the high state	−0.5 V to V_{CC}
Current into any output in the low state: SN54F241	96 mA
SN74F241	128 mA
Operating free-air temperature range: SN54F241	−55°C to 125°C
SN74F241	0°C to 70°C
Storage temperature range	−65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.

recommended operating conditions

		SN54F241			SN74F241			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{IK}	Input clamp current			−18			−18	mA
I_{OH}	High-level output current			−12			−15	mA
I_{OL}	Low-level output current			48			64	mA
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54F241			SN74F241			UNIT
				MIN	TYP†	MAX	MIN	TYP†	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.2			−1.2	V
V_{OH}		V_{CC} = 4.5 V	I_{OH} = −3 mA	2.4	3.3		2.4	3.3		V
			I_{OH} = −12 mA	2	3.2					
			I_{OH} = −15 mA				2	3.1		
		V_{CC} = 4.75 V,	I_{OH} = −3 mA				2.7			
V_{OL}		V_{CC} = 4.5 V	I_{OL} = 48 mA		0.38	0.55				V
			I_{OL} = 64 mA					0.42	0.55	
I_{OZH}		V_{CC} = 5.5 V,	V_O = 2.7 V			50			50	µA
I_{OZL}		V_{CC} = 5.5 V,	V_O = 0.5 V			−50			−50	µA
I_I		V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}		V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	µA
I_{IL}	OE or $\overline{OE}$	V_{CC} = 5.5 V,	V_I = 0.5 V			−1			−1	mA
	Any A					−1.6			−1.6	
I_{OS}‡		V_{CC} = 5.5 V,	V_O = 0	−100		−225	−100		−225	mA
I_{CC}		V_{CC} = 5.5 V	Outputs high		40	60		40	60	mA
			Outputs low		60	90		60	90	
			Outputs disabled		60	90		60	90	

† All typical values are at V_{CC} = 5 V, T_A = 25°C.
‡ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

TEXAS
INSTRUMENTS

switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 50 pF, R_L = 500 Ω, T_A = 25°C			V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX†				UNIT
			'F241			SN54F241		SN74F241		
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Any A	Y	1.7	3.6	5.2	1.2	6.5	1.7	6.2	ns
t_{PHL}			1.7	3.6	5.2	1.2	7	1.7	6.5	
t_{PZH}	$\overline{OE}$ or OE	Y	1.2	3.9	5.7	1.2	7	1.2	6.7	ns
t_{PZL}			1.2	5	7	1.2	8.5	1.2	8	
t_{PHZ}	$\overline{OE}$ or OE	Y	1.2	4.1	6	1.2	7	1.2	7	ns
t_{PLZ}			1.2	4.1	6	1.2	7.5	1.2	7	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
NOTE 2: Load circuits and waveforms are shown in Section 1.

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